Self-Protected Low Side Driver with Temperature and Current Limit

NCV8402 is a three terminal protected Low-Side Smart Discrete device. The protection features include overcurrent, overtemperature, ESD and integrated Drain-to-Gate clamping for overvoltage protection. This device offers protection and is suitable for harsh automotive environments.

Features

- Short-Circuit Protection
- Thermal Shutdown with Automatic Restart
- Overvoltage Protection
- Integrated Clamp for Inductive Switching
- ESD Protection
- dV/dt Robustness
- Analog Drive Capability (Logic Level Input)
- RoHs Compliant
- AEC-Q101 Qualified
- NCV Prefix for Automotive and Other Applications Requiring Site and Change Control
- These are Pb-Free Devices

Typical Applications

- Switch a Variety of Resistive, Inductive and Capacitive Loads
- Can Replace Electromechanical Relays and Discrete Circuits
- Automotive / Industrial

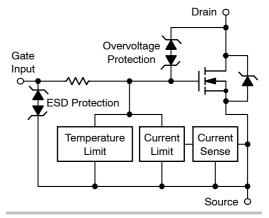


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS} (Clamped)	R _{DS(ON)} TYP	I _D MAX		
42 V	165 mΩ @ 10 V	2.0 A*		

^{*}Max current limit value is dependent on input condition.

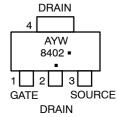






1

SOT-223 CASE 318E STYLE 3



A = Assembly Location

Y = Year

W = Work Week

8402 = Specific Device Code

= Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NCV8402STT1G	SOT-223 (Pb-Free)	1000/Tape & Reel
NCV8402STT3G	SOT-223 (Pb-Free)	4000/Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

	Symbol	Value	Unit	
Drain-to-Source Voltage Internally Cla	V_{DSS}	42	V	
Drain-to-Gate Voltage Internally Clar	nped $(R_G = 1.0 \text{ M}\Omega)$	V_{DGR}	42	V
Gate-to-Source Voltage		V_{GS}	±14	V
Continuous Drain Current	I _D	Internally Limited		
Power Dissipation	@ T _A = 25°C (Note 1) @ T _A = 25°C (Note 2) @ T _T = 25°C (Note 1)	P _D	1.1 1.7 8.9	W
Thermal Resistance	Junction-to-Ambient Steady State (Note 1) Junction-to-Ambient Steady State (Note 2) Junction-to-Tab Steady State (Note 1)	R _{θJA} R _{θJA} R _{θJT}	114 72 14	°C/W
Single Pulse Drain–to–Source Avalanche Energy (V _{DD} = 32 V, V _G = 5.0 V, I _{PK} = 1.0 A, L = 300 mH, R _{G(ext)} = 25 Ω)			150	mJ
Load Dump Voltage $(V_{GS} = 0 \text{ and } 10 \text{ V}, R_I = 2.0 \Omega, R_L = 9.0 \Omega, t_d = 400 \text{ ms})$			87	V
Operating Junction Temperature			-40 to 150	°C
Storage Temperature	T _{stg}	-55 to 150	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface–mounted onto min pad FR4 PCB, (2 oz. Cu, 0.06" thick).

- 2. Surface-mounted onto 2" sq. FR4 board (1" sq., 1 oz. Cu, 0.06" thick).

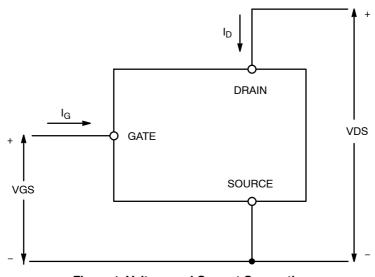


Figure 1. Voltage and Current Convention

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Test Condition	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS				•	•	•
Drain-to-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_J = 25^{\circ}\text{C}$	V _{(BR)DSS}	42	46	55	V
(Note 3)	V _{GS} = 0 V, I _D = 10 mA, T _J = 150°C (Note 5)	. ,	40	45	55	
Zero Gate Voltage Drain Current	V _{GS} = 0 V, V _{DS} = 32 V, T _J = 25°C	I _{DSS}		0.25	4.0	μΑ
	V _{GS} = 0 V, V _{DS} = 32 V, T _J = 150°C (Note 5)			1.1	20	
Gate Input Current	V _{DS} = 0 V, V _{GS} = 5.0 V	I _{GSSF}		50	100	μΑ
ON CHARACTERISTICS (Note 3)			•	•	•	•
Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 150 \mu A$	V _{GS(th)}	1.3	1.8	2.2	V
Gate Threshold Temperature Coefficient		V _{GS(th)} /T _J		4.0		-mV/°C
Static Drain-to-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 1.7 \text{ A}, T_J = 25^{\circ}\text{C}$	R _{DS(on)}		165	200	mΩ
	V _{GS} = 10 V, I _D = 1.7 A, T _J = 150°C (Note 5)			305	400	
	V _{GS} = 5.0 V, I _D = 1.7 A, T _J = 25°C			195	230	1
	V _{GS} = 5.0 V, I _D = 1.7 A, T _J = 150°C (Note 5)			360	460	
	V _{GS} = 5.0 V, I _D = 0.5 A, T _J = 25°C			190	230	
	V _{GS} = 5.0 V, I _D = 0.5 A, T _J = 150°C (Note 5)			350	460	
Source-Drain Forward On Voltage	V _{GS} = 0 V, I _S = 7.0 A	V _{SD}		1.0		V
SWITCHING CHARACTERISTICS (Note	5)		l.	I	I	I
Turn-ON Time (10% V _{IN} to 90% I _D)	V _{GS} = 10 V, V _{DD} = 12 V	t _{ON}		25		μs
Turn-OFF Time (90% V _{IN} to 10% I _D)	$I_D = 2.5 \text{ A}, R_L = 4.7 \Omega$	t _{OFF}		120		
Slew-Rate ON (70% V _{DS} to 50% V _{DS})	V _{GS} = 10 V, V _{DD} = 12 V,	-dV _{DS} /dt _{ON}		0.8		V/µs
Slew-Rate OFF (50% V _{DS} to 70% V _{DS})	$R_L = 4.7 \Omega$	dV _{DS} /dt _{OFF}		0.3		
SELF PROTECTION CHARACTERISTIC	S (T, _I = 25°C unless otherwise noted) (Note 4)		•	•	•
Current Limit	V _{DS} = 10 V, V _{GS} = 5.0 V, T _J = 25°C	I _{LIM}	3.7	4.3	5.0	A
	V _{DS} = 10 V, V _{GS} = 5.0 V, T _J = 150°C (Note 5)		2.3	3.0	3.7	
	V _{DS} = 10 V, V _{GS} = 10 V, T _J = 25°C		4.2	4.8	5.4	1
	V _{DS} = 10 V, V _{GS} = 10 V, T _J = 150°C (Note 5)		2.7	3.6	4.5	
Temperature Limit (Turn-off)	V _{GS} = 5.0 V (Note 5)	T _{LIM(off)}	150	175	200	°C
Thermal Hysteresis	V _{GS} = 5.0 V	$\Delta T_{LIM(on)}$		15		
Temperature Limit (Turn-off)	V _{GS} = 10 V (Note 5)	$T_{LIM(off)}$	150	165	185	
Thermal Hysteresis	V _{GS} = 10 V	$\Delta T_{LIM(on)}$		15		
GATE INPUT CHARACTERISTICS (Note	9 5)					
Device ON Gate Input Current	$V_{GS} = 5 \text{ V I}_{D} = 1.0 \text{ A}$	I_{GON}		50		μΑ
	V _{GS} = 10 V I _D = 1.0 A			400		
Current Limit Gate Input Current	V _{GS} = 5 V, V _{DS} = 10 V	I _{GCL}		0.05		mA
	V _{GS} = 10 V, V _{DS} = 10 V			0.4		
Thermal Limit Fault Gate Input Current	V _{GS} = 5 V, V _{DS} = 10 V	I _{GTL}		0.15		mA
	V _{GS} = 10 V, V _{DS} = 10 V			0.7		<u> </u>
ESD ELECTRICAL CHARACTERISTICS	5 (T _J = 25°C unless otherwise noted) (No	ote 5)				
Electro-Static Discharge Capability	Human Body Model (HBM)	ESD	4000			V
	Machine Model (MM)		400]

- Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Fault conditions are viewed as beyond the normal operating range of the part.
 Not subject to production testing.

TYPICAL PERFORMANCE CURVES

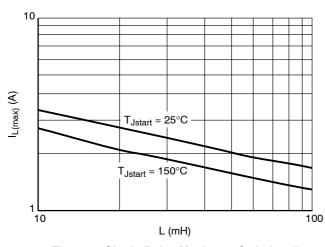


Figure 2. Single Pulse Maximum Switch-off Current vs. Load Inductance

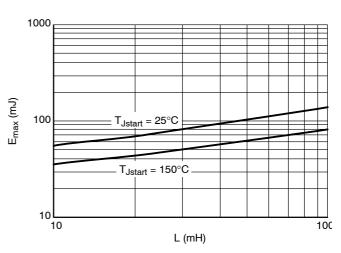


Figure 3. Single Pulse Maximum Switching Energy vs. Load Inductance

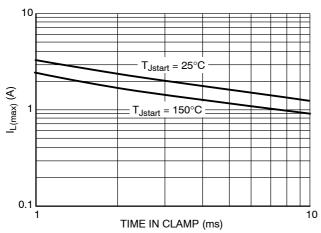


Figure 4. Single Pulse Maximum Inductive Switch-off Current vs. Time in Clamp

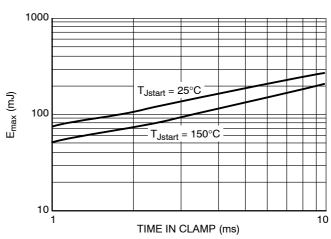


Figure 5. Single Pulse Maximum Inductive Switching Energy vs. Time in Clamp

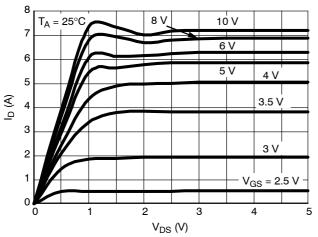


Figure 6. On-state Output Characteristics

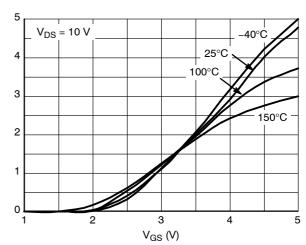


Figure 7. Transfer Characteristics

l_D (A)

TYPICAL PERFORMANCE CURVES

ILIM (A)

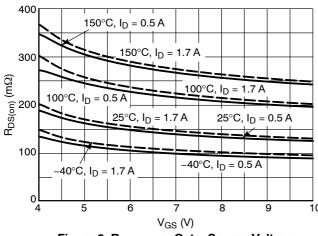


Figure 8. R_{DS(on)} vs. Gate-Source Voltage

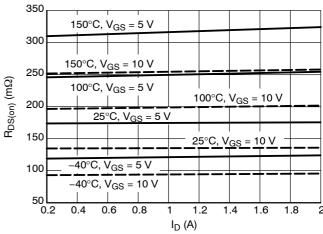


Figure 9. R_{DS(on)} vs. Drain Current

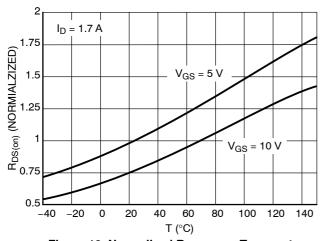


Figure 10. Normalized R_{DS(on)} vs. Temperature

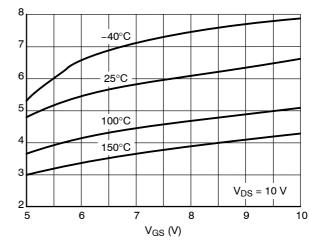


Figure 11. Current Limit vs. Gate-Source Voltage

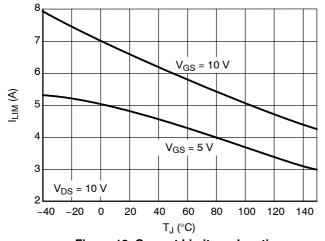


Figure 12. Current Limit vs. Junction Temperature

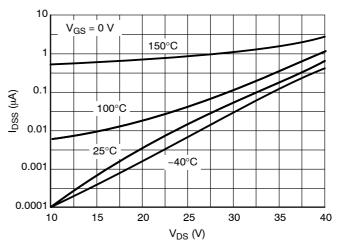


Figure 13. Drain-to-Source Leakage Current

TYPICAL PERFORMANCE CURVES

DRAIN-SOURCE VOLTAGE SLOPE (V/µs)

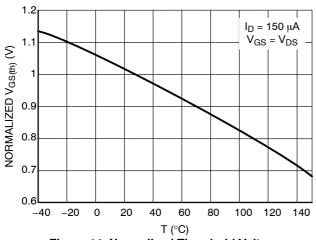


Figure 14. Normalized Threshold Voltage vs.
Temperature

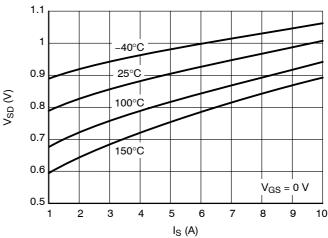


Figure 15. Source-Drain Diode Forward
Characteristics

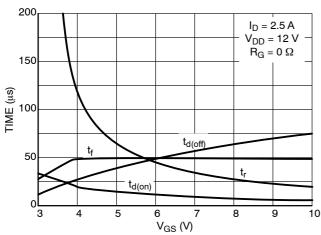


Figure 16. Resistive Load Switching Time vs.

Gate-Source Voltage

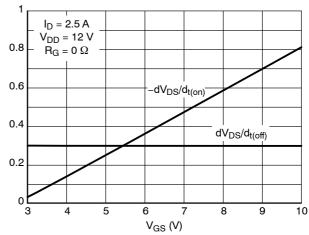


Figure 17. Resistive Load Switching
Drain-Source Voltage Slope vs. Gate-Source
Voltage

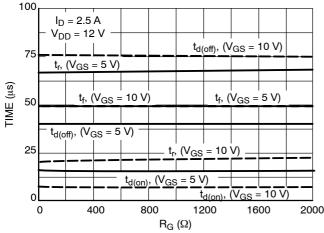


Figure 18. Resistive Load Switching Time vs.

Gate Resistance

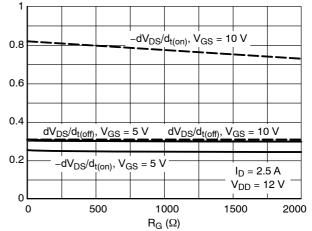


Figure 19. Drain-Source Voltage Slope during Turn On and Turn Off vs. Gate Resistance

DRAIN-SOURCE VOLTAGE SLOPE (V/µs)

TYPICAL PERFORMANCE CURVES

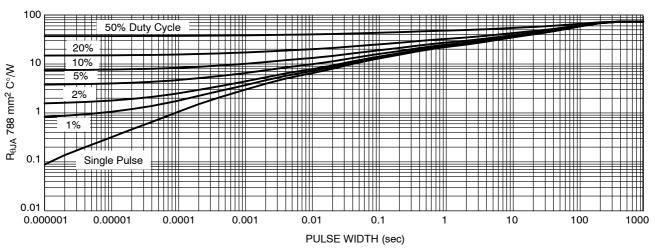


Figure 20. Transient Thermal Resistance

TEST CIRCUITS AND WAVEFORMS

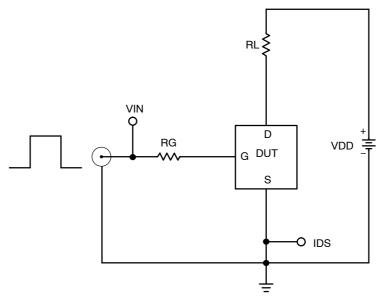


Figure 21. Resistive Load Switching Test Circuit

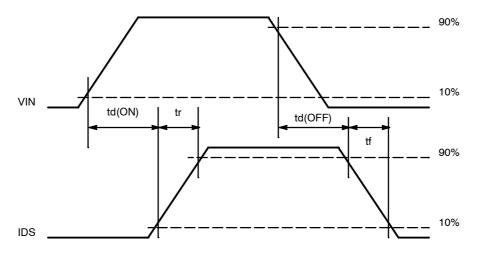


Figure 22. Resistive Load Switching Waveforms

TEST CIRCUITS AND WAVEFORMS

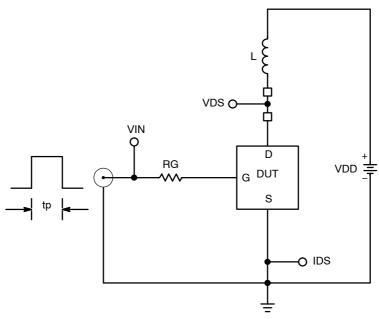


Figure 23. Inductive Load Switching Test Circuit

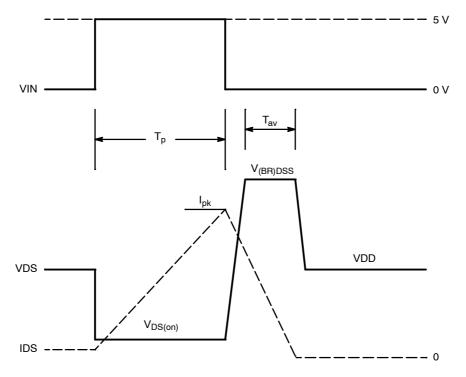
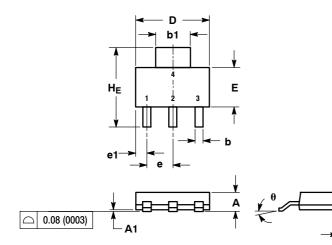


Figure 24. Inductive Load Switching Waveforms

PACKAGE DIMENSIONS

SOT-223 (TO-261) CASE 318E-04 ISSUE M



NOTES

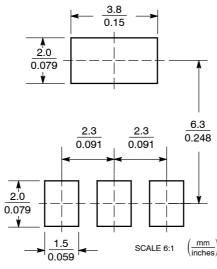
- 1. DIMENSIONING AND TOLERANCING PER ANSI
 - Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: INCH.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	1.50	1.63	1.75	0.060	0.064	0.068
A1	0.02	0.06	0.10	0.001	0.002	0.004
b	0.60	0.75	0.89	0.024	0.030	0.035
b1	2.90	3.06	3.20	0.115	0.121	0.126
С	0.24	0.29	0.35	0.009	0.012	0.014
D	6.30	6.50	6.70	0.249	0.256	0.263
E	3.30	3.50	3.70	0.130	0.138	0.145
е	2.20	2.30	2.40	0.087	0.091	0.094
e1	0.85	0.94	1.05	0.033	0.037	0.041
L1	1.50	1.75	2.00	0.060	0.069	0.078
HE	6.70	7.00	7.30	0.264	0.276	0.287
A	0°	_	10°	0°	_	10°

STYLE 3:

- PIN 1. GATE 2. DRAIN
- 2. DHAIN 3. SOURCE
- 4. DRAIN

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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